Dockson No.: 4468-020

PATENT

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Inventor(s): TOMITA, MASAYUKI

Confirmation No.5837

U.S. Patent Application No. 09/901,150

Group Art Unit: 2133

Filed: July 10, 2001

Examiner: BAKER, Stephen M.

For:

BIT ERROR MEASUREMENT APPARATUS AND METHOD AND RECORDING

**MEDIUM** 

## INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed more than three months after the U.S. filing date and after the mailing date of the first Office Action on the merits, but before the mailing date of the Final Rejection or Notice of Allowance.

## **CERTIFICATION PARAGRAPH**

The undersigned hereby certifies that each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the

information disclosure statement (37 CFR 1.97 (e)(1)). A copy of the foreign search report is enclosed for the Examiner's information.

Respectfully submitted,

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Date: August 31, 2004

FILING

DATE

U.S. PATENT

09/901,150

**GROUP** 

**SUBCLASS** 

2133

**CLASS** 

APPLICATION NO.

## ATTY. DOCKET NO. MATION DISCLOSURE 4468-020 CITATION IN AN APPLICANT **APPLICATION** TOMITA, MASAYUKI FILING DATE (PTO-1449) July 10, 2001 U.S. PATENT DOCUMENTS **EXAMINER'S** PATENT NO. DATE NAME INITIALS **DAO-LONG CHEN** 5,726,991 3-10-98

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	0961437	12.01.1999	EP				
	96/17454	06.06.1996	WIPO				
	0637150	01.02.1995	EP				
	OTHE	R ART (Including A	uthor, Title, Date, Perti	nent Pages, Etc	•)		
	OTHE	ER ART (Including A	uthor, Title, Date, Perti	nent Pages, Etc	•	_	

FOREIGN PATENT DOCUMENTS

**EXAMINER** DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.